

**Search Notes**

Application/Control No.

10/722,265

Examiner

Shih-yung Hsieh

Applicant(s)/Patent under  
Reexamination

CHANG, SHUN-HWA

Art Unit

2837

**SEARCHED**

Class	Subclass	Date	Examiner
84	453		
	380R		
	384		
	382		
	387R		
42	95	4/22/05	SWJ

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
BRS Tex + Search	4/22/05	SWJ

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner